



Features

- CRM(CQ) Super_Junction technology
- Much lower Ron*A performance for On-state efficiency
- Better efficiency due to very low FOM
- Ultra-fast body diode
- Qualified for industrial grade applications according to JEDEC

Applications

- LED/LCD/PDP TV and monitor Lighting
- Solar/Renewable/UPS-Micro Inverter System
- Charger
- Power Supply

Product Summary

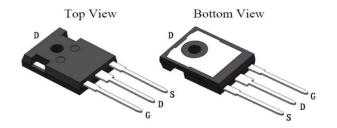
| VDS | 650V |
|-------------------|------|
| $R_{DS(on)_typ}$ | 90mΩ |
| I_{D} | 31A |

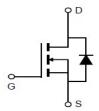
100% DVDS Tested

100% Avalanche Tested









Package Marking and Ordering Information

| Part # | Marking | Package | Packing | Reel Size | Tape Width | Qty |
|---------------|---------------|-----------|---------|-----------|------------|-------|
| CRJQ99N65G2BF | CRJQ99N65G2BF | TO-247-3L | Tube | N/A | N/A | 25pcs |

Absolute Maximum Ratings

| Parameter | Symbol | Value | Unit |
|---------------------------------------------------------------------------------------|------------------------|---------|------|
| Drain-source voltage | V _{DS} | 650 | V |
| Continuous drain current 1) | | | |
| $T_C = 25$ °C | ${ m I}_{ m D}$ | 31 | Α |
| $T_{C} = 100^{\circ}C$ | | 20 | |
| Pulsed drain current $^{2)}(T_{C} = 25^{\circ}C, t_{p} \text{ limited by } T_{jmax})$ | ${ m I}_{ m D\ pulse}$ | 93 | Α |
| Avalanche energy, single pulse (L=30mH) | E _{AS} | 480 | mJ |
| MOSFET dv/dt ruggedness | dv/dt | 50 | V/ns |
| Gate-Source voltage | V _{GS} | ±30 | V |
| Power dissipation ($T_C = 25$ °C) | P _{tot} | 255 | W |
| Continuous diode forward current($T_C = 25$ °C) | I _S | 31 | А |
| Diode pulse current ²⁾ (T _C = 25°C) | I _{S pulse} | 93 | А |
| Recovery diode dv/dt ³⁾ | dv/dt | 50 | V/ns |
| Operating junction and storage temperature | T_j , T_{stg} | -55+150 | °C |

¹⁾ Limited by Tj,max. Maximum Duty Cycle D = 0.50 2) Pulse width to limited by Ti.max

³⁾ Identical low side and high side switch with identical RG



CRJQ99N65G2BF

SJMOS N-MOSFET 650V, $90m\Omega$, 31A

Thermal Resistance

| Parameter | Symbol | Value | | | Unit | Test Condition |
|-------------------------------------------|-------------------|-------|------|------|-------|----------------|
| raiametei | Symbol | min. | typ. | max. | Oilit | rest condition |
| Thermal resistance, junction – case | R _{thJC} | - | 0.35 | 0.49 | °C/W | |
| Thermal resistance, junction – ambient | R _{thJA} | - | - | 46 | °C/W | |

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

| Davameter | Cumbal | | Value | | Unit | Test Condition |
|----------------------------------|---------------------|------|-------|------|------|--------------------------------------------|
| Parameter | Symbol | min. | typ. | max. | Unit | lest Condition |
| Static Characteristic | | | | | | |
| Drain-source breakdown voltage | BV_{DSS} | 650 | - | - | V | V _{GS} =0V, I _D =250uA |
| Gate threshold voltage | V _{GS(th)} | 2.9 | - | 4.9 | V | $V_{DS}=V_{GS}$, $I_{D}=250$ uA |
| | | | | | | V _{DS} =650V,V _{GS} =0V |
| Zero gate voltage drain current | I_{DSS} | - | - | 5 | μΑ | T _j =25°C |
| | | - | 800 | - | | T _j =150°C |
| Gate-source leakage current | I_{GSS} | - | - | ±100 | nA | V_{GS} =±30V, V_{DS} =0V |
| | | | | | | V _{GS} =10V, I _D =17A, |
| Drain-source on-state resistance | $R_{DS(on)}$ | - | 90 | 103 | mΩ | T _j =25°C |
| | | - | 230 | - | | T _j =150°C |
| Transconductance | g _{fs} | | 19 | | S | V _{DS} =20V,I _D =17A |

Dynamic Characteristic

| Input Capacitance | C _{iss} | - | 1900 | - | | |
|------------------------------|----------------------|---|------|---|----|---------------------------------------------------------------------|
| Output Capacitance | C _{oss} | - | 117 | - | pF | V_{GS} =0V, V_{DS} =100V, f=1MHz |
| Reverse Transfer Capacitance | C _{rss} | - | 2.2 | - | | |
| Gate Total Charge | Q_{G} | - | 70 | - | | |
| Gate-Source charge | Q _{gs} | - | 17 | - | nC | V _{GS} =10V, V _{DS} =480V, I _D =17A |
| Gate-Drain charge | Q_{gd} | - | 45 | - | | |
| Gate plateau voltage | V _{plateau} | - | 7.7 | - | V | |
| Turn-on delay time | t _{d(on)} | - | 50 | - | | |
| Rise time | t _r | - | 80 | - | nc | $V_{GS}=10V, I_{D}=17A, V_{DS}=400V, R_{g}=27\Omega$ |
| Turn-off delay time | t _{d(off)} | - | 180 | - | ns | |
| Fall time | t _f | - | 50 | - | | |
| Gate resistance | R_{gint} | - | 0.9 | - | Ω | f=1MHz |



CRJQ99N65G2BF

SJMOS N-MOSFET 650V, $90m\Omega$, 31A

Body Diode Characteristic

| Darameter | Value | | | | Took Condition | | |
|---------------------------------------|-----------------|---------|-----------|-----|----------------|---------------------------|--|
| Parameter | Symbol | min. | typ. max. | | Unit | Test Condition | |
| Body Diode Forward Voltage | V _{SD} | 0.7 | 0.9 | 1.1 | V | $V_{GS}=0V,I_{SD}=17A$ | |
| Body Diode Reverse Recovery Time | t _{rr} | - 140 - | | ns | Isd=17A | | |
| Body Diode Reverse Recovery Charge | Q _{rr} | - | 0.89 | - | uC | dI/dt=100A/us Vds=400V | |



Typical Performance Characteristics

Fig 1. Output Characteristics (Tj=25℃)

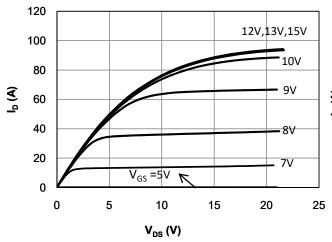


Fig 2. Output Characteristics (Tj=150℃)

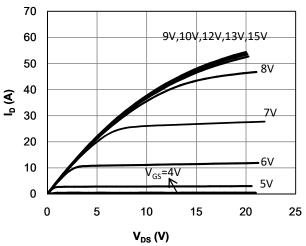


Fig 3: Transfer Characteristics

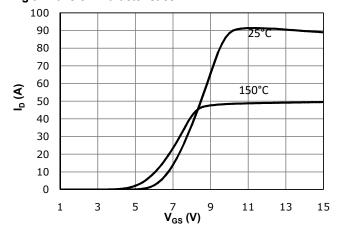


Fig 4: V_{TH} Vs Tj Temperature

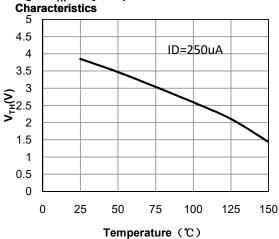


Fig 5: Rdson Vs Ids Characteristics(Tj=25℃)

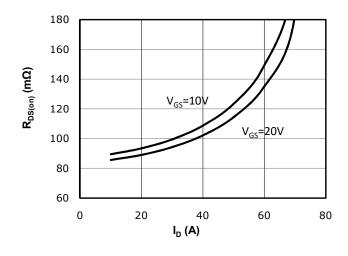


Fig 6: Rds(on) vs. Temperature

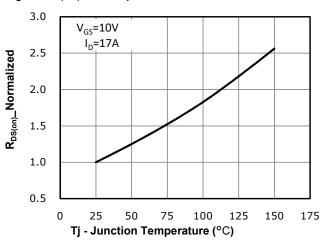




Fig 7: BVDSS vs. Temperature

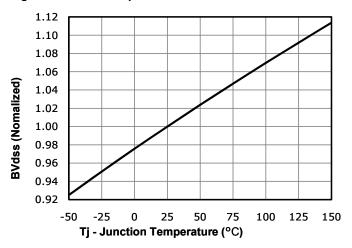


Fig 8: Rds(on) vs Gate Voltage

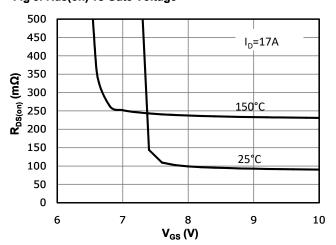


Fig 9: Body-diode Forward Characteristics

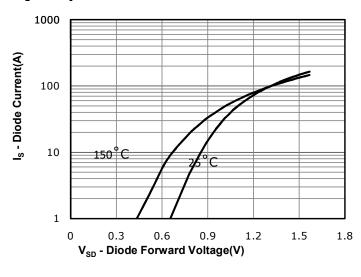


Fig 10: Gate Charge Characteristics

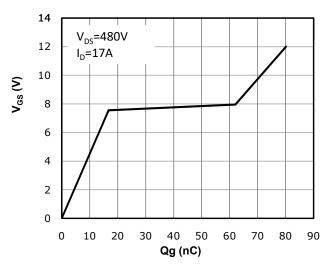


Fig 11: Capacitance Characteristics

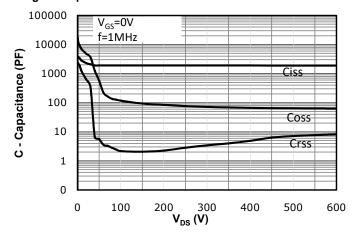
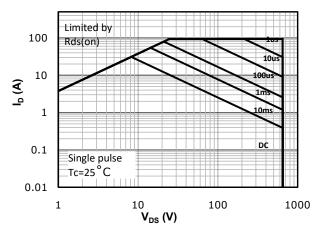
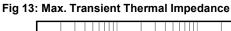
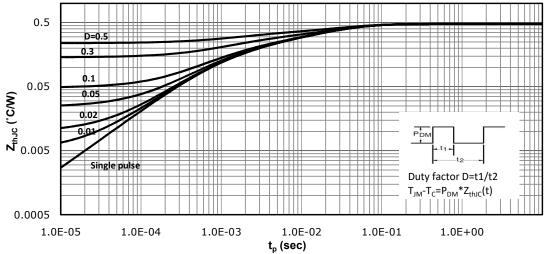


Fig 12: Safe Operating Area



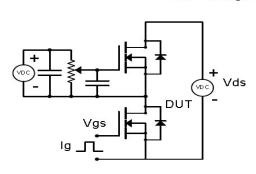


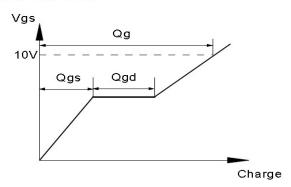




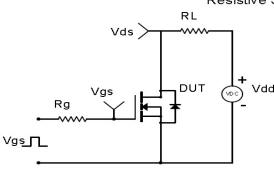
Test Circuit & Waveform

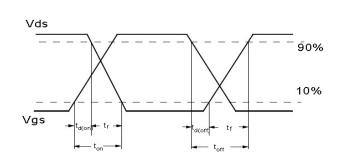
Gate Charge Test Circuit & Waveform



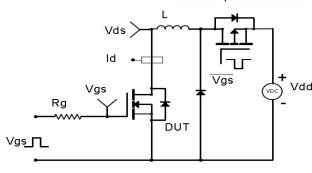


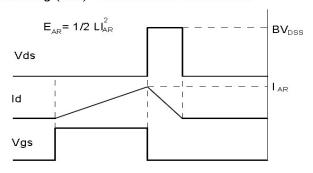
Resistive Switching Test Circuit & Waveforms



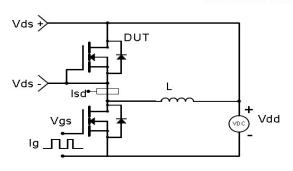


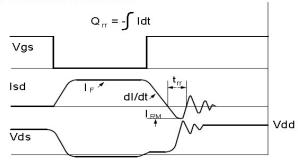
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





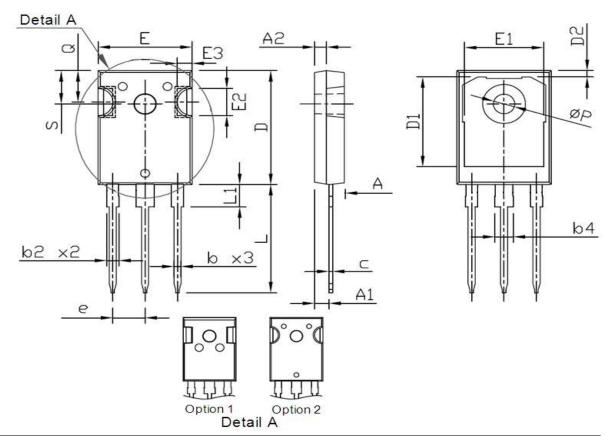
Diode Recovery Test Circuit & Waveforms







Package Outline: TO-247-3L



| Symbol | Dimensions In I | Millimeters | Dimensions In Inches | | |
|--------|-----------------|-------------|----------------------|--------|--|
| Symbol | Min. | Max. | Min. | Max. | |
| Α | 4.70 | 5.30 | 0.185 | 0.209 | |
| A1 | 2.20 | 2.60 | 0.087 | 0.102 | |
| A2 | 1.50 | 2.49 | 0.059 | 0.098 | |
| b | 1.04 | 1.33 | 0.041 | 0.052 | |
| b2 | 1.90 | 2.41 | 0.075 | 0.095 | |
| b4 | 2.87 | 3.43 | 0.113 | 0.135 | |
| С | 0.55 | 0.70 | 0.022 | 0.028 | |
| D | 20.70 | 21.30 | 0.815 | 0.839 | |
| D1 | 16.25 | 17.65 | 0.640 | 0.695 | |
| D2 | 0.51 | 1.40 | 0.020 | 0.055 | |
| е | 5.44 BS | C. | 0.214 | 4 BSC. | |
| E | 15.50 | 16.30 | 0.610 | 0.642 | |
| E1 | 13.08 | 14.16 | 0.515 | 0.557 | |
| E2 | 3.80 | 5.49 | 0.150 | 0.216 | |
| E3 | 1.00 | 2.75 | 0.039 | 0.108 | |
| L | 19.72 | 20.32 | 0.776 | 0.800 | |
| L1 | 3.85 | 4.50 | 0.152 | 0.177 | |
| Q | 5.25 | 6.25 | 0.207 | 0.246 | |
| Р | 3.50 | 3.70 | 0.138 | 0.146 | |
| S | 6.04 | 6.30 | 0.238 | 0.248 | |



Marking



NOTE:

NXBBAAAAY

X —Assembly location code

BB —Fab code AAAA —Lot code Y —Bin code

Revision History

| IXCVISIOII | instory | |
|------------|-----------|---------------|
| Revison | Date | Major changes |
| 1.0 | 2022/9/14 | First version |

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qulified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semicondutor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.